

TYPES 2N884 THRU 2N888
P-N-P-N PLANAR SILICON REVERSE-BLOCKING TRIODE THYRISTORS

350 ma DC — 15 v to 150 v

20 μ a GATE SENSITIVITY

ALL PLANAR, OXIDE-PASSIVATED JUNCTIONS

*mechanical data

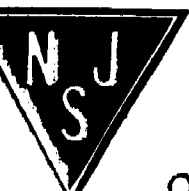
	<p>THE ANODE IS IN ELECTRICAL CONTACT WITH THE CASE. THE GATE TERMINAL IS CONNECTED TO A P REGION. ALL JEDEC TO-18 DIMENSIONS AND NOTES ARE APPLICABLE.</p>	
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*absolute maximum ratings at (or below) 100°C case temperature (unless otherwise noted)

	2N884	2N885	2N886	2N887	2N888	UNIT
Continuous Forward Blocking Voltage, V_{FR} (See Note 1)	15	30	60	100	150	v
Continuous Reverse Blocking Voltage, V_{RR} (See Note 2)	15	30	60	100	150	v
Continuous Anode Forward Current, I_F (See Note 3)	350					ma
Repetitive Peak Anode Forward Current (See Note 4)	20					a
Peak Anode Surge Current (See Note 5)	20					a
Peak Gate Reverse Voltage	5					v
Peak Gate Forward Current (Pulse width \leq 8 msec)	250					ma
Operating Case Temperature Range	-65 to 150					°C
Storage Temperature Range	-65 to 150					°C
Lead Temperature $\frac{1}{16}$ Inch from Case for 10 Seconds	230					°C

- NOTES: 1. These values apply when the gate-cathode resistance $R_{GK} \leq 1 \text{ k}\Omega$.
 2. These values apply when the gate-cathode resistance $R_{GK} \geq 1 \text{ k}\Omega$.
 3. This value applies for continuous d-c operation with resistive load. Above 100°C derate according to Figure 1.
 4. This value applies for square-wave pulses, PRR ≥ 60 pps, duty cycle $\leq 0.1\%$, when the device is operating at (or below) rated values of peak reverse blocking voltage and anode forward current.
 5. This value applies for one 200- μ sec square wave when the device is operating at (or below) rated values of peak reverse blocking voltage and anode forward current. Surge may be repeated after the device has returned to original thermal equilibrium.

*Indicates JEDEC registered data.



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TYPES 2N884 THRU 2N888

P-N-P-N PLANAR SILICON REVERSE-BLOCKING TRIODE THYRISTORS

*electrical characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT
I_{FR} Static Anode Forward Blocking Current	$V_F = \text{Rated } V_{FR}, R_{GK} = 1 \text{ k}\Omega$		1	μA
	$V_R = \text{Rated } V_{FR}, R_{GK} = 1 \text{ k}\Omega, T_C = 125^\circ\text{C}$		20	μA
I_{RR} Static Anode Reverse Blocking Current	$V_R = \text{Rated } V_{RR}, R_{GK} = 1 \text{ k}\Omega$		1	μA
	$V_R = \text{Rated } V_{RR}, R_{GK} = 1 \text{ k}\Omega, T_C = 125^\circ\text{C}$		20	μA
I_{GR} Gate Reverse Current	$V_{GR} = 2 \text{ v}, I_A = 0$		10	μA
I_{GT} Gate Trigger Current	$V_{AA} = 5 \text{ v}, R_L = 100 \Omega, PW_G \geq 10 \mu\text{sec}$		20	μA
V_{GT} Gate Trigger Voltage	$V_{AA} = 5 \text{ v}, R_L = 100 \Omega, PW_G \geq 10 \mu\text{sec}$	0.44	0.6	v
I_H Holding Current	$V_{AA} = 5 \text{ v}, I_G = -50 \mu\text{A}$	0.1	1	ma
V_F Forward Voltage	$I_F = 0.2 \text{ a}, R_{GK} \geq 1 \text{ k}\Omega, \text{ See Note 6}$		1.5	v

NOTE 6: The initial instantaneous value is measured using pulse techniques. Anode-pulse width = 300 μsec , PRR = 10 pps.
*Indicates JEDEC registered data.

thermal characteristics

PARAMETER	TYP	UNIT
θ_{J-C} Junction-to-Case Thermal Resistance	60	$^\circ\text{C}/\text{w}$
θ_{J-A} Junction-to-Free-Air Thermal Resistance	275	$^\circ\text{C}/\text{w}$

THERMAL INFORMATION

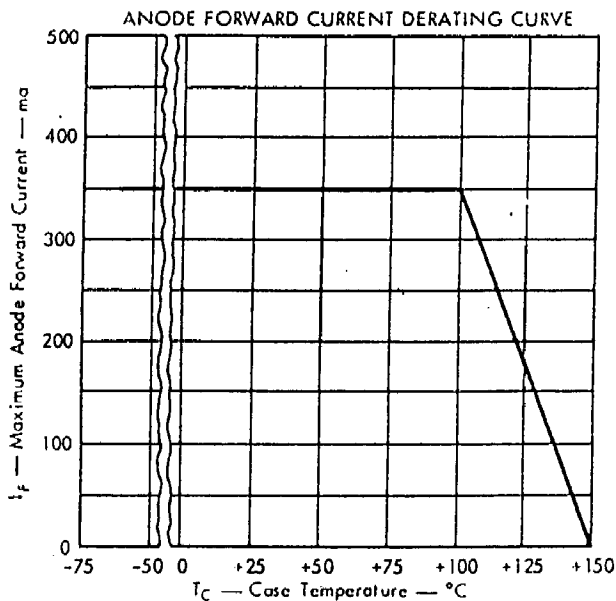


FIGURE 1

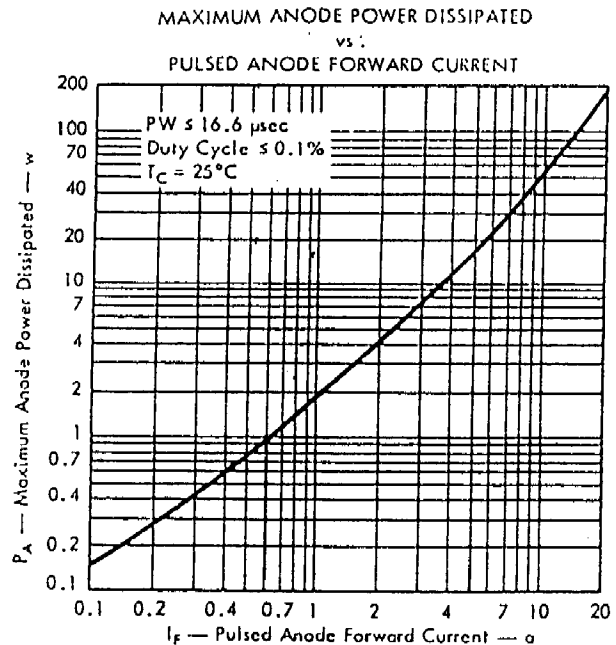


FIGURE 2